

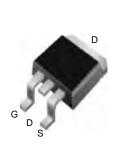
# N-Channel 650 V (D-S) Super Junction MOSFET

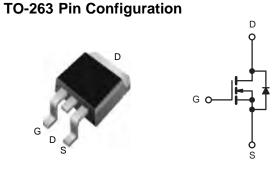
PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}$ (mΩ) Typ.	I <sub>D</sub> (A)	Q <sub>g</sub> (TYP.)		
650	75 at V <sub>GS</sub> = 10 V	45	78 nC		

#### **FEATURES**

- Super Junction Power MOSFET
- Low R<sub>DS(ON)</sub>
- Avalanche energy rated (UIS)







Top View

N-Channel MOSFET

### **APPLICATIONS**

- SMPS with PFC, Flyback and LLC topologies
- Micro inverter with DC/AC inverter topology

ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub> = 25 °C, unless otherwise noted)						
PARAMETER	SYMBOL	LIMIT	UNIT			
Drain-Source Voltage	V <sub>DS</sub>	650	V			
Gate-Source Voltage	V <sub>GS</sub>	± 30	v			
Continuous Drain Current (T,I = 150 °C)	T <sub>C</sub> = 25 °C		45			
Continuous Drain Current (1 <sub>J</sub> = 150 °C)	T <sub>C</sub> = 100 °C	I <sub>D</sub>	32	A		
Pulsed Drain Current (t = 100 μs)	I <sub>DM</sub>	180				
Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	43			
Single Avalanche Energy <sup>a</sup>	L = U. I IIII	E <sub>AS</sub>	530	mJ		
Manipular Danier Discipation 3	T <sub>C</sub> = 25 °C	В	389 <sup>b</sup>	W		
Maximum Power Dissipation <sup>a</sup>	T <sub>C</sub> = 100 °C	P <sub>D</sub>	194.5 <sup>b</sup>	vv		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C		

THERMAL RESISTANCE RATINGS							
PARAMETER	SYMBOL	LIMIT	UNIT				
Junction-to-Ambient (PCB Mount) <sup>c</sup>	t ≤ 10 s	R <sub>thJA</sub>	65	°C // /			
Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	0.35	°C/W			

#### Notes

- a. Duty cycle ≤ 1 %.
- b. See SOA curve for voltage derating.
- c. When mounted on 1" square PCB (FR4 material).

1 Rev. 1.0



PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static						
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	650	-	-	V
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu A$ $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$		-	4	V
Gate-Body Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA
Zero Gate Voltage Drain Current		V <sub>DS</sub> = 650 V, V <sub>GS</sub> = 0 V -		-	1	
	I <sub>DSS</sub>	V <sub>DS</sub> = 650 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 100 °C	-	-	10	μA
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$	45	-	-	Α
Drain-Source On-State Resistance a	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A	-	75	90	mΩ
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 20 A	-	25	-	S
Dynamic <sup>b</sup>						
Input Capacitance	C <sub>iss</sub>		-	4510	-	pF
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 100 V, f = 1 MHz	-	503	-	
Reverse Transfer Capacitance	C <sub>rss</sub>		-	10	-	
Total Gate Charge <sup>c</sup>	Qg		-	78	-	nC
Gate-Source Charge <sup>c</sup>	Q <sub>gs</sub>	$V_{DS} = 480 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$	-	28	-	
Gate-Drain Charge <sup>c</sup>	Q <sub>gd</sub>		-	24	-	
Gate Resistance	$R_g$	f = 1 MHz	-	2.5	-	Ω
Turn-On Delay Time <sup>c</sup>	t <sub>d(on)</sub>		-	51	-	
Rise Time <sup>c</sup>	t <sub>r</sub>	$V_{DS} = 480 \text{ V}, I_{D} = 20 \text{ A}, R_{g} = 5\Omega$	-	60	-	
Turn-Off Delay Time <sup>c</sup>	t <sub>d(off)</sub>	V <sub>GEN</sub> = 10 V	-	109	-	ns
Fall Time <sup>c</sup>	t <sub>f</sub>		-	35	-	
Drain-Source Body Diode Ratings and	Characteristi	cs <sup>b</sup> (T <sub>C</sub> = 25 °C)				
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C	-	-	45	Α
Pulsed Current (t = 100 μs)	I <sub>SM</sub>		-	-	180	Α
Forward Voltage <sup>a</sup>	$V_{SD}$	I <sub>F</sub> = 20 A, V <sub>GS</sub> = 0 V	-	-	1.2	V
Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 20 A, di/dt = 100 A/µs,	-	395	-	ns
Reverse Recovery Charge	Q <sub>rr</sub>	V <sub>DS</sub> = 480 V	-	11	_	μC

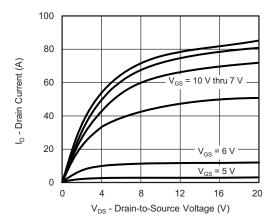
#### Notes

- a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %.
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

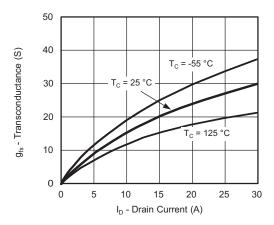
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



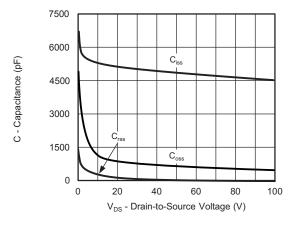
### **TYPICAL CHARACTERISTICS** ( $T_A = 25$ °C, unless otherwise noted)



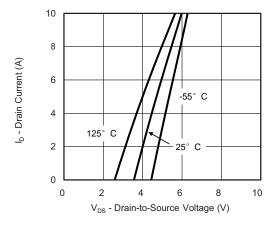
#### **Output Characteristics**



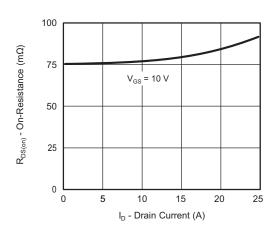
Transconductance



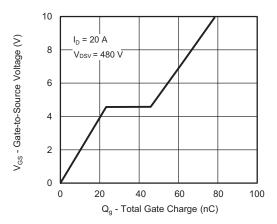
Capacitance



**Transfer Characteristics** 



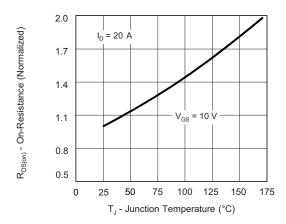
On-Resistance vs. Drain Current



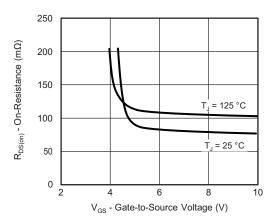
**Gate Charge** 



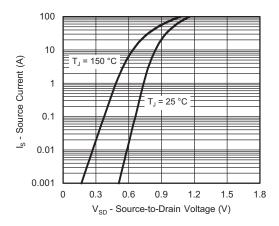
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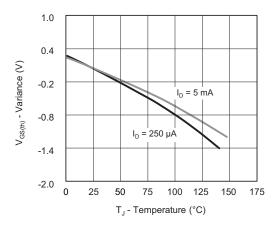
On-Resistance vs. Junction Temperature



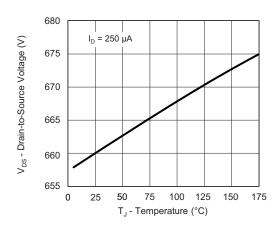
On-Resistance vs. Gate-to-Source Voltage



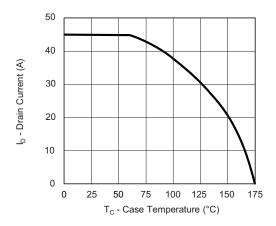
Source Drain Diode Forward Voltage



**Threshold Voltage** 



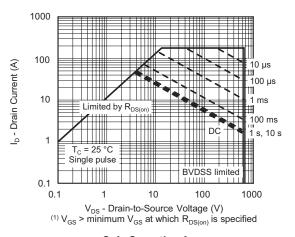
**Drain Source Breakdown vs. Junction Temperature** 



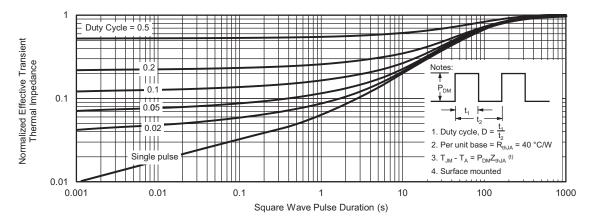
**Current De-Rating** 



### **THERMAL RATINGS** ( $T_A = 25$ °C, unless otherwise noted)

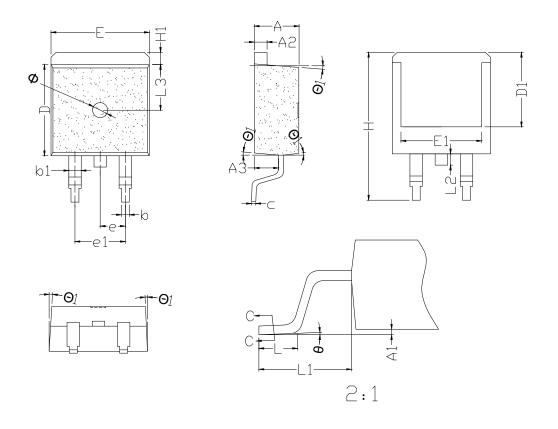


Safe Operating Area



Normalized Thermal Transient Impedance, Junction-to-Ambient

# **TO-263 PACKAGE OUTLINE**



### **COMMON DIMENSIONS** (UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	TYP	MAX	SYMBOL	MIN	TYP	MAX
Α	4.10	4.50	4.80	е	2.35	2.54	2.75
A1	0.00	0.10	0.30	e1	5.08REF		
A2	1.10	1.30	1.50	Н	14.50	15.15	16.00
A3	2.15	2.50	3.10	H1	1.00	1.28	1.75
b	0.60	0.80	1.05	L	1.80	2.23	2.90
b1	1.05	1.33	1.50	L1	4.30	4.75	5.50
С	0.33	0.50	0.66	L2	1.00	1.30	1.85
D	8.40	9.20	9.60	L3	0.90	4.65	9.00
D1	7.50REF		ф	0°	2°	5°	
E	9.60	10.02	10.80	φ1	2°	-	7°
E1	7.60	9.88	10.30	Φ	1.5BSC		





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